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"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

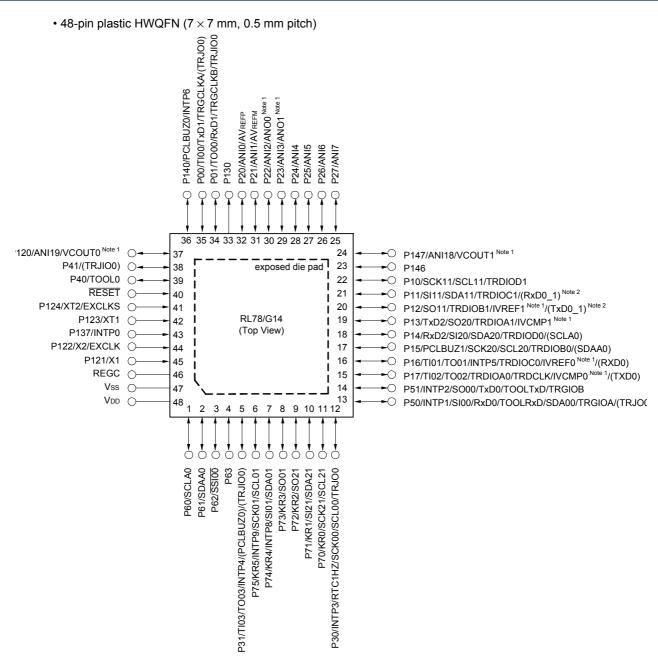
Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Obsolete
Core Processor	RL78
Core Size	16-Bit
Speed	32MHz
Connectivity	CSI, I <sup>2</sup> C, LINbus, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	48
Program Memory Size	96KB (96K x 8)
Program Memory Type	FLASH
EEPROM Size	8K x 8
RAM Size	12K x 8
Voltage - Supply (Vcc/Vdd)	1.6V ~ 5.5V
Data Converters	A/D 12x8/10b; D/A 2x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LFQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f104lfafb-v0

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RL78/G14 1. OUTLINE



- Note 1. Mounted on the 96 KB or more code flash memory products.
- Note 2. Mounted on the 384 KB or more code flash memory products.
- Caution Connect the REGC pin to Vss pin via a capacitor (0.47 to 1  $\mu$ F).
- Remark 1. For pin identification, see 1.4 Pin Identification.
- Remark 2. Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register 0, 1 (PIOR0, 1).
- Remark 3. It is recommended to connect an exposed die pad to Vss.

RL78/G14 1. OUTLINE

Note

The flash library uses RAM in self-programming and rewriting of the data flash memory.

The target products and start address of the RAM areas used by the flash library are shown below.

R5F104xJ (x = F, G, J, L, M, P): Start address F9F00H

For the RAM areas used by the flash library, see **Self RAM list of Flash Self-Programming Library for RL78 Family (R20UT2944)**.

#### **Absolute Maximum Ratings**

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Parameter	Symbols		Conditions	Ratings	Unit
Output current, high	Іон1	Per pin P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P130, P140 to P147		-40	mA
		Total of all pins	P00 to P04, P40 to P47, P102, P120, P130, P140 to P145	-70	mA
		-170 mA	P05, P06, P10 to P17, P30, P31, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100, P101, P110, P111, P146, P147	-100	mA
	Іон2	Per pin	P20 to P27, P150 to P156	-0.5	mA
		Total of all pins		-2	mA
Output current, low	lOL1	Per pin	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P130, P140 to P147	40	mA
		Total of all pins	P00 to P04, P40 to P47, P102, P120, P130, P140 to P145	70	mA
		170 mA	P05, P06, P10 to P17, P30, P31, P50 to P57, P60 to P67, P70 to P77, P80 to P87, P100, P101, P110, P111, P146, P147	100	mA
	lol2	Per pin	P20 to P27, P150 to P156	1	mA
		Total of all pins		5	mA
Operating ambient tem-	TA	In normal c	operation mode	-40 to +85	°C
perature		In flash me	emory programming mode		
Storage temperature	Tstg			-65 to +150	°C

Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

#### 2.2 Oscillator Characteristics

## 2.2.1 X1, XT1 characteristics

 $(TA = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{VDD} \le 5.5 \text{ V}, \text{Vss} = 0 \text{ V})$ 

Resonator	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock oscillation frequency (fx) Note	Ceramic resonator/	$2.7~\text{V} \leq \text{Vdd} \leq 5.5~\text{V}$	1.0		20.0	MHz
	crystal resonator	2.4 V ≤ V <sub>DD</sub> < 2.7 V	1.0		16.0	
		1.8 V ≤ V <sub>DD</sub> < 2.4 V	1.0		8.0	
		1.6 V ≤ V <sub>DD</sub> < 1.8 V	1.0		4.0	
XT1 clock oscillation frequency (fxT) Note	Crystal resonator		32	32.768	35	kHz

Note Indicates only permissible oscillator frequency ranges. Refer to AC Characteristics for instruction execution time.

Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.

Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

Remark When using the X1 oscillator and XT1 oscillator, refer to 5.4 System Clock Oscillator in the RL78/G14 User's Manual.

## 2.2.2 On-chip oscillator characteristics

 $(TA = -40 \text{ to } +85^{\circ}C, 1.6 \text{ V} \le \text{VDD} \le 5.5 \text{ V}, \text{ Vss} = 0 \text{ V})$ 

Oscillators	Parameters	C	conditions	MIN.	TYP.	MAX.	Unit
High-speed on-chip oscillator clock frequency Notes 1, 2	fı⊢		1		32	MHz	
High-speed on-chip oscillator clock frequency		-20 to +85°C	$1.8 \text{ V} \le \text{Vdd} \le 5.5 \text{ V}$	-1.0		+1.0	%
accuracy			1.6 V ≤ V <sub>DD</sub> < 1.8 V	-5.0		+5.0	%
		-40 to -20°C	1.8 V ≤ VDD < 5.5 V	-1.5		+1.5	%
			1.6 V ≤ V <sub>DD</sub> < 1.8 V	-5.5		+5.5	%
Low-speed on-chip oscillator clock frequency	fı∟				15		kHz
Low-speed on-chip oscillator clock frequency accuracy				-15		+15	%

**Note 1.** High-speed on-chip oscillator frequency is selected with bits 0 to 4 of the option byte (000C2H) and bits 0 to 2 of the HOCODIV register.

Note 2. This only indicates the oscillator characteristics. Refer to AC Characteristics for instruction execution time.



(TA = -40 to +85°C, 1.6 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

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Items	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Output current, low Note 1	IOL1	Per pin for P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P130, P140 to P147				20.0 Note 2	mA
		Per pin for P60 to P63				15.0 Note 2	mA
		Total of P00 to P04, P40 to P47,	4.0 V ≤ EVDD0 ≤ 5.5 V			70.0	mA
		(When duty ≤ 70% Note 3) 1.	2.7 V ≤ EV <sub>DD0</sub> < 4.0 V			15.0	mA
			1.8 V ≤ EVDD0 < 2.7 V			9.0	mA
			1.6 V ≤ EVDD0 < 1.8 V			4.5	mA
		Total of P05, P06, P10 to P17,	4.0 V ≤ EVDD0 ≤ 5.5 V			80.0	mA
		P30, P31, P50 to P57,	2.7 V ≤ EVDD0 < 4.0 V			35.0	mA
		P60 to P67, P70 to P77, P80 to P87, P100, P101, P110,	1.8 V ≤ EVDD0 < 2.7 V			20.0	mA
		P111, P146, P147 (When duty ≤ 70% Note 3)	1.6 V ≤ EVDD0 < 1.8 V			10.0	mA
		Total of all pins (When duty ≤ 70% <sup>Note 3</sup> )				150.0	mA
	lOL2	Per pin for P20 to P27, P150 to P156				0.4 Note 2	mA
		Total of all pins (When duty ≤ 70% <sup>Note 3</sup> )	1.6 V ≤ VDD ≤ 5.5 V			5.0	mA

- **Note 1.** Value of current at which the device operation is guaranteed even if the current flows from an output pin to the EVsso, EVss1, and Vss pins.
- Note 2. Do not exceed the total current value.
- **Note 3.** Specification under conditions where the duty factor  $\leq 70\%$ .

The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

• Total output current of pins = (IoL × 0.7)/(n × 0.01)

<Example> Where n = 80% and lol = 10.0 mA

Total output current of pins =  $(10.0 \times 0.7)/(80 \times 0.01) \approx 8.7 \text{ mA}$ 

However, the current that is allowed to flow into one pin does not vary depending on the duty factor.

A current higher than the absolute maximum rating must not flow into one pin.

(TA = -40 to +85°C, 1.6 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, Vss = EVss0 = EVss1 = 0 V)

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Items	Symbol	Conditi	ons		MIN.	TYP.	MAX.	Unit
Input leakage cur- rent, high	ILIH1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P140 to P147	VI = EVDD0				1	μΑ
	ILIH2	P20 to P27, P137, P150 to P156, RESET	VI = VDD				1	μΑ
	ILIH3	P121 to P124 (X1, X2, EXCLK, XT1, XT2, EXCLKS)	VI = VDD	In input port or external clock input			1	μΑ
				In resonator con- nection			10	μА
Input leakage current, low	ILIL1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P140 to P147	Vı = EVsso				-1	μΑ
	ILIL2	P20 to P27, P137, P150 to P156, RESET	Vı = Vss				-1	μΑ
	ILIL3	P121 to P124 (X1, X2, EXCLK, XT1, XT2, EXCLKS)	VI = VSS	In input port or external clock input			-1	μА
				In resonator con- nection			-10	μА
On-chip pull-up resistance	Rυ	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P140 to P147	Vi = EVsso	, In input port	10	20	100	kΩ

# (2) Flash ROM: 96 to 256 KB of 30- to 100-pin products $(TA = -40 \text{ to } +85^{\circ}\text{C}, \ 1.6 \text{ V} \leq \text{EVDD0} = \text{EVDD1} \leq \text{VDD} \leq 5.5 \text{ V}, \ \text{Vss} = \text{EVss0} = \text{EVss1} = 0 \text{ V})$

(2/2)

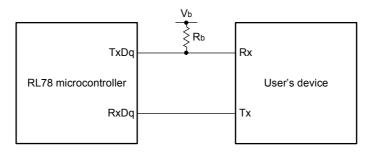
Parameter	Symbol			Conditions		MIN.	TYP.	MAX.	Unit
Supply cur-	IDD2	HALT mode	HS (high-speed main)	fHOCO = 64 MHz,	V <sub>DD</sub> = 5.0 V		0.79	3.32	mA
rent Note 1	Note 2		mode Note 7	fih = 32 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.79	3.32	
				fHOCO = 32 MHz,	V <sub>DD</sub> = 5.0 V		0.49	2.63	
				fih = 32 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.49	2.63	
				fHOCO = 48 MHz,	V <sub>DD</sub> = 5.0 V		0.62	2.57	
				fiH = 24 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.62	2.57	
				fHOCO = 24 MHz,	V <sub>DD</sub> = 5.0 V		0.4	2.00	
				fih = 24 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.4	2.00	
				fHOCO = 16 MHz,	V <sub>DD</sub> = 5.0 V		0.38	1.49	
				fiH = 16 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.38	1.49	
			LS (low-speed main)	fhoco = 8 MHz,	V <sub>DD</sub> = 3.0 V		250	800	μА
			mode Note 7	fiH = 8 MHz Note 4	V <sub>DD</sub> = 2.0 V		250	800	
			LV (low-voltage main)	fHOCO = 4 MHz,	V <sub>DD</sub> = 3.0 V		420	755	μА
			mode Note 7	fiH = 4 MHz Note 4	V <sub>DD</sub> = 2.0 V		420	755	
			HS (high-speed main)	f <sub>MX</sub> = 20 MHz Note 3,	Square wave input		0.30	1.63	mA
			mode Note 7	V <sub>DD</sub> = 5.0 V	Resonator connection		0.40	1.85	
				f <sub>MX</sub> = 20 MHz Note 3,	Square wave input		0.30	1.63	
				V <sub>DD</sub> = 3.0 V	Resonator connection		0.40	1.85	
				f <sub>MX</sub> = 10 MHz Note 3,	Square wave input		0.20	0.89	
				V <sub>DD</sub> = 5.0 V	Resonator connection		0.25	0.97	
				f <sub>MX</sub> = 10 MHz Note 3,	Square wave input		0.20	0.89	
				V <sub>DD</sub> = 3.0 V	Resonator connection		0.25	0.97	
			LS (low-speed main)	f <sub>MX</sub> = 8 MHz Note 3,	Square wave input		110	580	μΑ
			mode Note 7	V <sub>DD</sub> = 3.0 V	Resonator connection		140	630	
				f <sub>MX</sub> = 8 MHz Note 3,	Square wave input		110	580	
				V <sub>DD</sub> = 2.0 V	Resonator connection		140	630	
			Subsystem clock oper-	fsuB = 32.768 kHz Note 5,	Square wave input		0.28	0.66	μΑ
			ation	TA = -40°C	Resonator connection		0.47	0.85	
				fsuB = 32.768 kHz Note 5,	Square wave input		0.34	0.66	
				TA = +25°C	Resonator connection		0.53	0.85	
				fsuB = 32.768 kHz Note 5,	Square wave input		0.37	2.35	
				TA = +50°C	Resonator connection		0.56	2.54	
				fsuB = 32.768 kHz Note 5,	Square wave input		0.61	4.08	
				TA = +70°C	Resonator connection		0.80	4.27	
				fsuB = 32.768 kHz Note 5,	Square wave input		1.55	8.09	
				T <sub>A</sub> = +85°C	Resonator connection		1.74	8.28	1
	IDD3	STOP mode	TA = -40°C	•	•		0.19	0.57	μΑ
	Note 6	Note 8	T <sub>A</sub> = +25°C				0.25	0.57	1
			T <sub>A</sub> = +50°C				0.33	2.26	1
			T <sub>A</sub> = +70°C				0.52	3.99	1
			T <sub>A</sub> = +85°C				1.46	8.00	1

(Notes and Remarks are listed on the next page.)

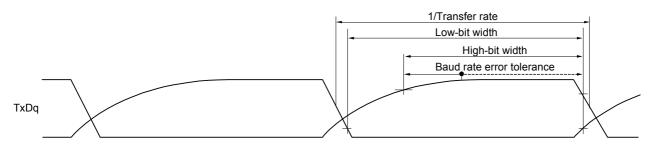
- Note 5. Current flowing only to the watchdog timer (including the operating current of the low-speed on-chip oscillator).

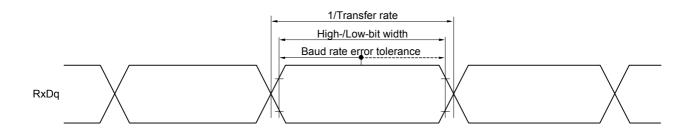
  The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and IWDT when the watchdog timer is in operation.
- Note 6. Current flowing only to the A/D converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IADC when the A/D converter operates in an operation mode or the HALT mode.
- Note 7. Current flowing only to the LVD circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and ILVD when the LVD circuit is in operation.
- Note 8. Current flowing during programming of the data flash.
- Note 9. Current flowing during self-programming.
- Note 10. For shift time to the SNOOZE mode, see 23.3.3 SNOOZE mode in the RL78/G14 User's Manual.
- **Note 11.** Current flowing only to the D/A converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IDAC when the D/A converter operates in an operation mode or the HALT mode.
- Note 12. Current flowing only to the comparator circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2, or IDD3 and ICMP when the comparator circuit is in operation.
- Note 13. A comparator and D/A converter are provided in products with 96 KB or more code flash memory.
- Remark 1. fil: Low-speed on-chip oscillator clock frequency
- Remark 2. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
- Remark 3. fclk: CPU/peripheral hardware clock frequency
- Remark 4. Temperature condition of the TYP. value is TA = 25°C

#### **UART** mode connection diagram (during communication at different potential)



#### UART mode bit width (during communication at different potential) (reference)





- Remark 1.  $Rb[\Omega]$ : Communication line (TxDq) pull-up resistance,
  - Cb[F]: Communication line (TxDq) load capacitance, Vb[V]: Communication line voltage
- Remark 2. q: UART number (q = 0 to 3), g: PIM and POM number (g = 0, 1, 5, 14)
- Remark 3. fmck: Serial array unit operation clock frequency
  - (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn).
  - m: Unit number, n: Channel number (mn = 00 to 03, 10 to 13))
- Remark 4. UART2 cannot communicate at different potential when bit 1 (PIOR01) of peripheral I/O redirection register 0 (PIOR0) is

#### 3.2 Oscillator Characteristics

### 3.2.1 X1, XT1 characteristics

#### $(TA = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{VDD} \le 5.5 \text{ V}, \text{Vss} = 0 \text{ V})$

Resonator	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock oscillation frequency (fx) Note	Ceramic resonator/	$2.7 \text{ V} \le \text{VDD} \le 5.5 \text{ V}$	1.0		20.0	MHz
	crystal resonator	2.4 V ≤ V <sub>DD</sub> < 2.7 V	1.0		16.0	
XT1 clock oscillation frequency (fxT) Note	Crystal resonator		32	32.768	35	kHz

Note Indicates only permissible oscillator frequency ranges. Refer to AC Characteristics for instruction execution time.

Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics

Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user.

Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

Remark When using the X1 oscillator and XT1 oscillator, refer to 5.4 System Clock Oscillator in the RL78/G14 User's Manual.

## 3.2.2 On-chip oscillator characteristics

#### $(TA = -40 \text{ to } +105^{\circ}C, 2.4 \text{ V} \le VDD \le 5.5 \text{ V}, \text{Vss} = 0 \text{ V})$

Oscillators	Parameters	Conditions		MIN.	TYP.	MAX.	Unit
High-speed on-chip oscillator clock frequency Notes 1, 2	fін			1		32	MHz
High-speed on-chip oscillator clock frequency		-20 to +85°C	$2.4 \text{ V} \le \text{VDD} \le 5.5 \text{ V}$	-1.0		+1.0	%
accuracy		-40 to -20°C	$2.4 \text{ V} \le \text{Vdd} \le 5.5 \text{ V}$	-1.5		+1.5	%
		+85 to +105°C	$2.4 \text{ V} \le \text{VDD} \le 5.5 \text{ V}$	-2.0		+2.0	%
Low-speed on-chip oscillator clock frequency	fıL				15		kHz
Low-speed on-chip oscillator clock frequency accuracy				-15		+15	%

Note 1. High-speed on-chip oscillator frequency is selected with bits 0 to 4 of the option byte (000C2H) and bits 0 to 2 of the HOCODIV register.

Note 2. This only indicates the oscillator characteristics. Refer to AC Characteristics for instruction execution time.

(TA = -40 to +105°C, 2.4 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

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Items	Symbol	Condition	ns	MIN.	TYP.	MAX.	Unit
Output voltage, high	Vон1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57,	4.0 V ≤ EVDD0 ≤ 5.5 V, IOH1 = -3.0 mA	EVDD0 - 0.7			V
		P80 to P87, P100 to P102, P110, P111, P120, P130, P140 to P147	2.7 V ≤ EVDD0 ≤ 5.5 V, IOH1 = -2.0 mA	EVDD0 - 0.6			V
			2.4 V ≤ EVDD0 ≤ 5.5 V, IOH1 = -1.5 mA	EVDD0 - 0.5			V
	VOH2	P20 to P27, P150 to P156	2.4 V ≤ VDD ≤ 5.5 V, IOH2 = -100 μA	VDD - 0.5			V
Output voltage, low	VOL1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57,	4.0 V ≤ EVDD0 ≤ 5.5 V, lol1 = 8.5 mA			0.7	V
		P80 to P87, P100 to P102, P110, P111, P120, P130, P140 to P147	2.7 V ≤ EVDD0 ≤ 5.5 V, loL1 = 3.0 mA			0.6	V
			2.7 V ≤ EVDD0 ≤ 5.5 V, loL1 = 1.5 mA			0.4	V
			2.4 V ≤ EVDD0 ≤ 5.5 V, IOL1 = 0.6 mA			0.4	V
	VOL2	P20 to P27, P150 to P156	$2.4~V \le V_{DD} \le 5.5~V$ , $I_{OL2} = 400~\mu A$			0.4	V
	Vol3	P60 to P63	4.0 V ≤ EVDD0 ≤ 5.5 V, IOL3 = 15.0 mA			2.0	V
			4.0 V ≤ EVDD0 ≤ 5.5 V, IOL3 = 5.0 mA			0.4	V
		-	2.7 V ≤ EVDD0 ≤ 5.5 V, IOL3 = 3.0 mA			0.4	V
			2.4 V ≤ EVDD0 ≤ 5.5 V, loL3 = 2.0 mA			0.4	V

Caution P00, P02 to P04, P10, P11, P13 to P15, P17, P30, P43 to P45, P50 to P55, P71, P74, P80 to P82, P142 to P144 do not output high level in N-ch open-drain mode.

- Note 1. Total current flowing into VDD and EVDD0, including the input leakage current flowing when the level of the input pin is fixed to VDD, EVDD0 or Vss, EVss0. The values below the MAX. column include the peripheral operation current. However, not including the current flowing into the A/D converter, LVD circuit, I/O port, and on-chip pull-up/pull-down resistors and the current flowing data flash rewrite.
- Note 2. When high-speed on-chip oscillator and subsystem clock are stopped.
- **Note 3.** When high-speed system clock and subsystem clock are stopped.
- Note 4. When high-speed on-chip oscillator and high-speed system clock are stopped. When AMPHS1 = 1 (Ultra-low power consumption oscillation). However, not including the current flowing into the RTC, 12-bit interval timer, and watchdog timer.
- Note 5. Relationship between operation voltage width, operation frequency of CPU and operation mode is as below. HS (high-speed main) mode:  $2.7 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}_{\textcircled{Q}}1 \text{ MHz}$  to 32 MHz  $2.4 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}_{\textcircled{Q}}1 \text{ MHz}$  to 16 MHz
- Remark 1. fmx: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)
- Remark 2. fHoco: High-speed on-chip oscillator clock frequency (64 MHz max.)

  Remark 3. fil: High-speed on-chip oscillator clock frequency (32 MHz max.)

  Remark 4. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
- Remark 5. Except subsystem clock operation, temperature condition of the TYP. value is TA = 25°C

<R>

## (3) Flash ROM: 384 to 512 KB of 48- to 100-pin products

(TA = -40 to +105°C, 2.4 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

(2/2)

Parameter	Symbol			Conditions		MIN.	TYP.	MAX.	Unit
Supply cur-	IDD2	HALT mode	HS (high-speed main)	fHOCO = 64 MHz,	V <sub>DD</sub> = 5.0 V		0.93	5.16	mA
rent Note 1	Note 2		mode Note 7	fih = 32 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.93	5.16	1
				fHOCO = 32 MHz,	V <sub>DD</sub> = 5.0 V		0.5	4.47	
				fih = 32 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.5	4.47	1
				fHOCO = 48 MHz,	V <sub>DD</sub> = 5.0 V		0.72	4.08	1
				fih = 24 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.72	4.08	1
				fHOCO = 24 MHz,	V <sub>DD</sub> = 5.0 V		0.42	3.51	1
				fih = 24 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.42	3.51	
				fHOCO = 16 MHz,	V <sub>DD</sub> = 5.0 V		0.39	2.38	
				fih = 16 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.39	2.38	
		fmx = 20 MHz Note 3,	Square wave input		0.31	2.83	mA		
			mode Note 7	V <sub>DD</sub> = 5.0 V	Resonator connection		0.41	2.92	
				f <sub>MX</sub> = 20 MHz Note 3,	Square wave input		0.31	2.83	
				V <sub>DD</sub> = 3.0 V	Resonator connection		0.41	2.92	
			f <sub>MX</sub> = 10 MHz Note 3,	Square wave input		0.21	1.46		
		V <sub>DD</sub> = 5.0 V	Resonator connection		0.26	1.57			
		f <sub>MX</sub> = 10 MHz Note 3,	fmx = 10 MHz Note 3,	Square wave input		0.21	1.46		
			V <sub>DD</sub> = 3.0 V	Resonator connection		0.26	1.57		
				Square wave input		0.31	0.76	μΑ	
			ation	TA = -40°C	Resonator connection		0.50	0.95	
			fsuB = 32.768	fsub = 32.768 kHz Note 5,	Square wave input		0.38	0.76	
				T <sub>A</sub> = +25°C	Resonator connection		0.57	0.95	•
				fsub = 32.768 kHz Note 5,	Square wave input		0.47	3.59	
				T <sub>A</sub> = +50°C	Resonator connection		0.70	3.78	
				fsub = 32.768 kHz Note 5,	Square wave input		0.80	6.20	
				T <sub>A</sub> = +70°C	Resonator connection		1.00	6.39	
				fsub = 32.768 kHz Note 5,	Square wave input		1.65	10.56	
				T <sub>A</sub> = +85°C	Resonator connection		1.84	10.75	
				fsub = 32.768 kHz Note 5,	Square wave input		8.00	65.7	
				T <sub>A</sub> = +105°C	Resonator connection		8.00	65.7	
	IDD3	STOP mode	T <sub>A</sub> = -40°C				0.19	0.63	μΑ
	Note 6	Note 8	T <sub>A</sub> = +25°C				0.30	0.63	
			T <sub>A</sub> = +50°C				0.41	3.47	
	T <sub>A</sub> = +70°C  T <sub>A</sub> = +85°C  T <sub>A</sub> = +105°C		T <sub>A</sub> = +70°C				0.80	6.08	1
			TA = +85°C				1.53	10.44	
					6.50	67.14			

(Notes and Remarks are listed on the next page.)

(3) When reference voltage (+) = VDD (ADREFP1 = 0, ADREFP0 = 0), reference voltage (-) = Vss (ADREFM = 0), target pin: ANI0 to ANI14, ANI16 to ANI20, internal reference voltage, and temperature sensor output voltage

(TA = -40 to +105°C, 2.4 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, Vss = EVss0 = EVss1 = 0 V, Reference voltage (+) = VDD, Reference voltage (-) = Vss)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Resolution	RES			8		10	bit
Overall error Note 1	AINL	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V		1.2	±7.0	LSB
Conversion time	tconv	10-bit resolution	3.6 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.125		39	μs
		Target pin: ANI0 to ANI14, ANI16 to ANI20	$2.7 \text{ V} \leq \text{V}_{DD} \leq 5.5 \text{ V}$	3.1875		39	μs
			2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V	17		39	μs
		10-bit resolution	$3.6 \text{ V} \leq \text{V}_{DD} \leq 5.5 \text{ V}$	2.375		39	μs
		Target pin: internal reference voltage, and temperature sensor output voltage	$2.7 \text{ V} \le \text{Vdd} \le 5.5 \text{ V}$	3.5625		39	μs
		(HS (high-speed main) mode)	$2.4 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}$	17		39	μs
Zero-scale error Notes 1, 2	Ezs	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V			±0.60	%FSR
Full-scale error Notes 1, 2	Ers	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V			±0.60	%FSR
Integral linearity error Note 1	ILE	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V			±4.0	LSB
Differential linearity error Note 1	DLE	10-bit resolution	$2.4~V \leq V_{DD} \leq 5.5~V$			±2.0	LSB
Analog input voltage	Vain	ANI0 to ANI14	-	0		VDD	V
		ANI16 to ANI20		0		EV <sub>DD0</sub>	٧
		nternal reference voltage 2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V, HS (high-speed main) mode)		V <sub>BGR</sub> Note 3			V
		Temperature sensor output voltage (2.4 V $\leq$ VDD $\leq$ 5.5 V, HS (high-speed main) r	mode)	V <sub>TMPS25</sub> Note 3			V

Note 1. Excludes quantization error (±1/2 LSB).

Note 2. This value is indicated as a ratio (% FSR) to the full-scale value.

Note 3. Refer to 3.6.2 Temperature sensor characteristics/internal reference voltage characteristic.

## 3.6.4 Comparator

(TA = -40 to +105°C, 2.4 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

Parameter	Symbol	Col	nditions	MIN.	TYP.	MAX.	Unit
Input voltage range	Ivref					EVDD0 - 1.4	V
	Ivcmp			-0.3		EV <sub>DD0</sub> + 0.3	V
Output delay	td	V <sub>DD</sub> = 3.0 V Input slew rate > 50 mV/μs	Comparator high-speed mode, standard mode			1.2	μs
			Comparator high-speed mode, window mode			2.0	μs
			Comparator low-speed mode, standard mode		3.0	5.0	μs
High-electric-potential reference voltage	VTW+	Comparator high-speed mode, window mode			0.76 VDD		V
Low-electric-potential ref- erence voltage	VTW-	Comparator high-speed mode, window mode			0.24 VDD		V
Operation stabilization wait time	tсмр			100			μs
Internal reference voltage Note	VBGR	$2.4~\text{V} \leq \text{V}_{\text{DD}} \leq 5.5~\text{V},~\text{HS}$ (high-speed main) mode		1.38	1.45	1.50	٧

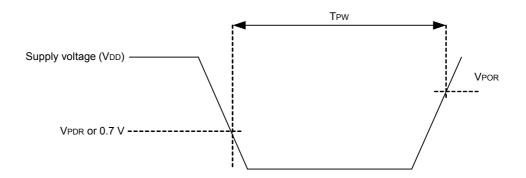
Note Not usable in sub-clock operation or STOP mode.

#### 3.6.5 POR circuit characteristics

#### $(TA = -40 \text{ to } +105^{\circ}\text{C}, Vss = 0 \text{ V})$

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Power on/down reset threshold	VPOR	Voltage threshold on VDD rising	1.45	1.51	1.57	V
	VPDR	Voltage threshold on VDD falling Note 1	1.44	1.50	1.56	V
Minimum pulse width Note 2	Tpw		300			μs

- **Note 1.** However, when the operating voltage falls while the LVD is off, enter STOP mode, or enable the reset status using the external reset pin before the voltage falls below the operating voltage range shown in 3.4 AC Characteristics.
- Note 2. Minimum time required for a POR reset when VDD exceeds below VPDR. This is also the minimum time required for a POR reset from when VDD exceeds below 0.7 V to when VDD exceeds VPOR while STOP mode is entered or the main system clock is stopped through setting bit 0 (HIOSTOP) and bit 7 (MSTOP) in the clock operation status control register (CSC).

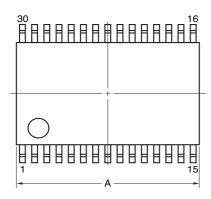


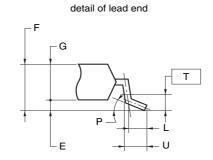
## 4. PACKAGE DRAWINGS

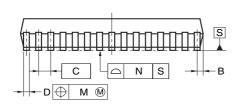
## 4.1 30-pin products

R5F104AAASP, R5F104ACASP, R5F104ADASP, R5F104AEASP, R5F104AFASP, R5F104AGASP R5F104AADSP, R5F104ACDSP, R5F104ADDSP, R5F104AEDSP, R5F104AFDSP, R5F104AGGSP, R5F104ACGSP, R5F104ACGSP, R5F104AGGSP, R5F104

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LSSOP30-0300-0.65	PLSP0030JB-B	S30MC-65-5A4-3	0.18

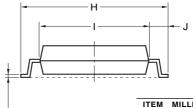






#### NOTE

Each lead centerline is located within 0.13 mm of its true position (T.P.) at maximum material condition.



ITEM	MILLIMETERS
Α	9.85±0.15
В	0.45 MAX.
С	0.65 (T.P.)
D	$0.24^{+0.08}_{-0.07}$
Е	0.1±0.05
F	1.3±0.1
G	1.2
Н	8.1±0.2
I	6.1±0.2
J	1.0±0.2
K	0.17±0.03
L	0.5
М	0.13
N	0.10
Р	3°+5°
Т	0.25
U	0.6±0.15

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# 4.5 44-pin products

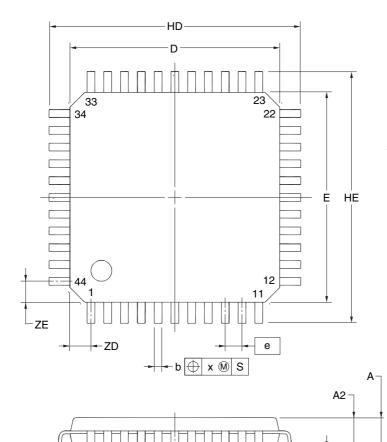
R5F104FAAFP, R5F104FCAFP, R5F104FDAFP, R5F104FEAFP, R5F104FFAFP, R5F104FAFP, R5F104FJAFP

 $R5F104FADFP,\,R5F104FCDFP,\,R5F104FDDFP,\,R5F104FEDFP,\,R5F104FFDFP,\,R5F104FGDFP,\,R5F104FFF,\,R5F104FFF,\,R5F104FFF,\,R5F104FF,\,R5F104FF,\,R5F104FF,\,R5F10$ 

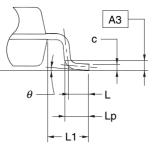
R5F104FHDFP, R5F104FJDFP R5F104FAGFP, R5F104FCGFP, R5F104FDGFP, R5F104FEGFP, R5F104FGGFP, R5F104FGFP, R5F104FGGFP, R5F104FGGFP, R5F104FGGFP, R5F104FGGFP, R5F104FGFP, R5F104FGGFP, R5F104FGFP, R5F104FFP, R5F104FFP, R5F104FFP, R5F104FFP, R5F104FFP, R5F104FFP, R5F104FFP, R5F104FFP, R5F104FFP, R5F104FF

R5F104FHGFP, R5F104FJGFP

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LQFP44-10x10-0.80	PLQP0044GC-A	P44GB-80-UES-2	0.36



detail of lead end



| TEM | DIMENSIONS | D | 10.00±0.20 | E | 10.00±0.20 | HD | 12.00±0.20 | HE | 12.00±0.20 | A | 1.60 MAX.

(UNIT:mm)

- ' '	1.00 107 174.
A1	0.10±0.05
A2	1.40±0.05
A3	0.25
b	$0.37^{+0.08}_{-0.07}$

b	$0.37^{+0.08}_{-0.07}$
С	$0.145^{+0.055}_{-0.045}$
L	0.50
Lp	0.60±0.15
L1	1.00±0.20
θ	3°+5°

L1	1.00±0.2
θ	3°+5° -3°
е	0.80
х	0.20

#### x 0.20 y 0.10 ZD 1.00 ZE 1.00

NOTE
Each lead centerline is located within 0.20 mm of its true position at maximum material condition.

y S

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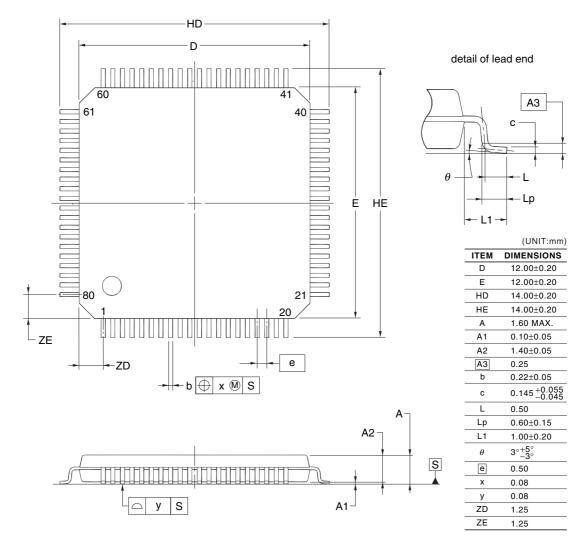
S

Α1

# 4.9 80-pin products

R5F104MFAFB, R5F104MGAFB, R5F104MHAFB, R5F104MJAFB R5F104MFDFB, R5F104MGDFB, R5F104MHDFB, R5F104MJDFB R5F104MFGFB, R5F104MGGFB, R5F104MHGFB, R5F104MJGFB

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LFQFP80-12x12-0.50	PLQP0080KE-A	P80GK-50-8EU-2	0.53



#### NOTE

Each lead centerline is located within 0.08 mm of its true position at maximum material condition.

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111	/ IOI	OI V	1110	

# RL78/G14 Datasheet

Rev.	Date		Description
Rev.	Date	Page	Summary
0.01	Feb 10, 2011	_	First Edition issued
0.02	May 01, 2011	1 to 2	1.1 Features revised
		3	1.2 Ordering Information revised
		4 to 13	1.3 Pin Configuration (Top View) revised
		14	1.4 Pin Identification revised
		15 to 17	1.5.1 30-pin products to 1.5.3 36-pin products revised
		23 to 26	1.6 Outline of Functions revised
0.03	Jul 28, 2011	1	1.1 Features revised
1.00	Feb 21, 2012	1 to 40	1. OUTLINE revised
		41 to 97	2. ELECTRICAL SPECIFICATIONS added
2.00	Oct 25, 2013	1	Modification of 1.1 Features
		3 to 8	Modification of 1.2 Ordering Information
		9 to 22	Modification of package type in 1.3 Pin Configuration (Top View)
		34 to 43	Modification of description of subsystem clock in 1.6 Outline of Functions
		34 to 43	Modification of description of timer output in 1.6 Outline of Functions
		34 to 43	Modification of error of data transfer controller in 1.6 Outline of Functions
		34 to 43	Modification of error of event link controller in 1.6 Outline of Functions
		45, 46	Modification of description of Tables in 2.1 Absolute Maximum Ratings
		47	Modification of Tables, notes, cautions, and remarks in 2.2 Oscillator Characteristics
		48	Modification of error of conditions of high level input voltage in 2.3.1 Pin characteristics
		49	Modification of error of conditions of low level output voltage in 2.3.1 Pin characteristics
		53 to 62	Modification of Notes and Remarks in 2.3.2 Supply current characteristics
		65, 66	Addition of Minimum Instruction Execution Time during Main System Clock Operation
		67 to 69	Addition of AC Timing Test Points
		70 to 97	Addition of LS mode and LV mode characteristics in 2.5.1 Serial array unit
		98 to 101	Addition of LS mode and LV mode characteristics in 2.5.2 Serial interface IICA
		102 to 105	Addition of characteristics about conversion of internal reference voltage and temperature sensor in 2.6.1 A/D converter characteristics
		107	Addition of characteristic in 2.6.4 Comparator
		107	Deletion of detection delay in 2.6.5 POR circuit characteristics
		109	Modification of 2.6.7 Power supply voltage rising slope characteristics
		110	Modification of 2.7 Data Memory STOP Mode Low Supply Voltage Data Retention Characteristics
		110	Addition of characteristic in 2.8 Flash Memory Programming Characteristics
		111	Addition of description in 2.10 Timing for Switching Flash Memory Programming Modes

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